TPS5410-Q1 Automotive, 1A, Wide Input Range, Step-Down SWIFT™ Converter

1 Features

- Qualified for automotive applications
- Wide input voltage range: 5.5V to 36V
- Up to 1A continuous (1.2A peak) output current
- High efficiency up to 95% enabled by 110mΩ integrated MOSFET switch
- Wide output voltage range: adjustable down to 1.22V with 1.5% initial accuracy
- Internal compensation minimizes external parts count
- Fixed 500kHz switching frequency for small filter size
- Improved line regulation and transient response by input voltage feed forward
- System protected by over current limiting, over voltage protection and thermal shutdown
- –40°C to 125°C operating junction temperature range
- Available in small 8-pin SOIC package

2 Applications

- Consumer: set-top box, DVD, LCD displays
- Industrial and car audio power supplies
- Battery chargers, high power LED supply
- 12V/24V distributed power systems

3 Description

As a member of the SWIFT™ converter family of DC/DC regulators, the TPS5410-Q1 is a high-output-current PWM converter that integrates a low resistance high side N-channel MOSFET. Included on the substrate with the listed features is a high performance voltage error amplifier that provides tight voltage regulation accuracy under transient conditions; an undervoltage-lockout circuit to prevent start-up until the input voltage reaches 5.5V; an internally set slow-start circuit to limit inrush currents; and a voltage feed-forward circuit to improve the transient response. Using the ENA pin, shutdown supply current is reduced to 18µA typically. Other features include an active high enable, overcurrent limiting, overvoltage protection and thermal shutdown. To reduce design complexity and external component count, the TPS5410-Q1 feedback loop is internally compensated.

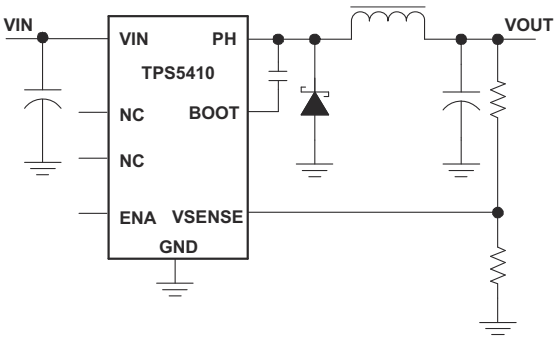
The TPS5410-Q1 device is available in an easy to use 8-pin SOIC package. TI provides evaluation modules and software tools to aid in quickly achieving high-performance power supply designs to meet aggressive equipment development cycles.

Package Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)
TPS5410-Q1	D (SOIC, 8)	4.9mm × 6mm

(1) For more information, see Section 10.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.

Simplified Schematic



Efficiency vs Output Current

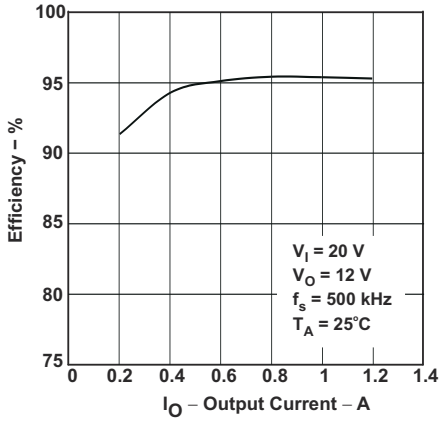


Table of Contents

4 Pin Configuration and Functions

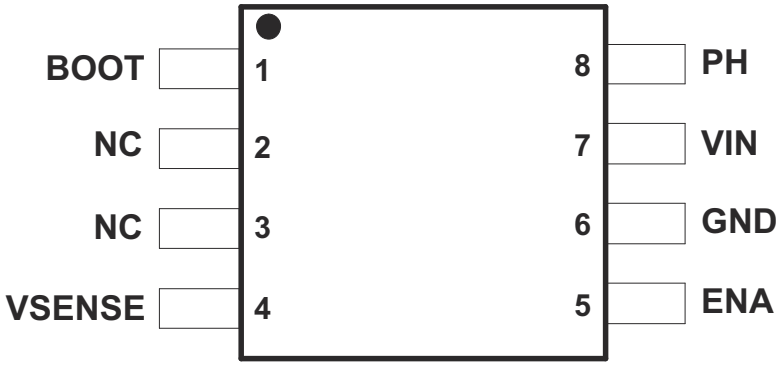


Figure 4-1. D Package, 8-Pin SOIC (Top View)

Table 4-1. Pin Functions

PIN		DESCRIPTION
NAME	NO.	
BOOT	1	Boost capacitor for the high-side FET gate driver. Connect 0.01µF low ESR capacitor from BOOT pin to PH pin.
NC	2, 3	Not connected internally
VSENSE	4	Feedback voltage for the regulator. Connect to output voltage divider.
ENA	5	On and off control. Below 0.5V, the device stops switching. Above 1.3V, the device starts switching. ENA can be left floating. This pin is internally connected to a 1.5MΩ pullup resistor. Do not connect this pin with a resistor to ground.
GND	6	Ground.
VIN	7	Input supply voltage. Bypass VIN pin to GND pin close to device package with a high quality, low ESR ceramic capacitor.
PH	8	Source of the high side power MOSFET. Connected to external inductor and diode.

5 Specifications

5.1 Absolute Maximum Ratings

Over operating junction temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
Input voltage	VIN(2) to GND	–0.3	40	V
Input voltage	ENA to GND	–0.3	7	V
Input voltage	VSENSE to GND	–0.3	3	V
Output voltage	BOOT to PH(3)	–0.3	6	V
Output voltage	BOOT to GND	–0.3		V
Output voltage	PH to GND, (Steady-state)(2)	–0.6	40	V
Output voltage	PH to GND, (transient < 10ns)	–1.2		V
Source current	PH		Internally Limited	
Source current	PH Leakage current		10	µA
T_J	Operating virtual junction temperature	–40	150	°C
T_{stg}	Storage temperature	–65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
(2) Approaching the absolute maximum rating for the VIN pin can cause the voltage on the PH pin to exceed the absolute maximum rating.
(3) BOOT to PH Abs MAX voltage is the maximum voltage that can be applied between BOOT and PH.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 HBM ESD Classification Level 2[1]	±2000	V
		Charged device model (CDM), per AEC Q100-011 CDM ESD Classification Level C5	±750	

(1) AEC Q100-002 indicates that HBM stressing must be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

5.3 Recommended Operating Conditions

Over operating junction temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Input voltage	Input voltage range	5.5		36	V
T_J	Operating junction temperature	–40		125	°C

5.4 Thermal Information

THERMAL METRIC[1]		TPS5410 -Q1 D (SOIC) 8 PINs	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance (Custom Board)[2]	75	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance (JESD 51-7)[3]	106	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	54	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	55	°C/W
ψ_{JT}	Junction-to-top characterization parameter	15	°C/W
ψ_{JB}	Junction-to-board characterization parameter	56	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.
(2) Refer to the TPS5420's EVM User's Guide for board layout and additional information. For thermal design information please see the Maximum Ambient Temperature section.
(3) The value of $R_{\Theta JA}$ given in this table is only valid for comparison with other packages and cannot be used for design purposes. These values were calculated in accordance with JESD 51-7, and simulated on a 4-layer JEDEC board. These values do not represent the performance obtained in an actual application. For example, the EVM $R_{\Theta JA}$ = 75 °C/W. For design information please see the *Maximum Ambient Temperature* section.

5.5 Electrical Characteristics

T_J = –40°C to +125°C, V_{IN} = 5.5V to 36V. Typical values are at T_J = 25°C and V_{IN} = 12V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY VOLTAGE (VIN PIN)						
$I_{Q(VIN)}$	VIN quiescent current	Non-switching, V_{SENSE} = 2V, PH pin open		2	4.4	mA
$I_{SD(VIN)}$	VIN shutdown supply current	Shutdown, ENA = 0V		15	50	µA
UVLO						
$VIN_{UVLO(R)}$	VIN UVLO rising threshold	V_{VIN} rising		5.3	5.5	V
$VIN_{UVLO(H)}$	VIN UVLO hysteresis			0.35		V
VOLTAGE REFERENCE						
V_{FB}	FB voltage	T_J = 25°C	1.202	1.221	1.239	V
V_{FB}	FB voltage	T_J = –40°C to 125°C	1.196	1.221	1.245	V
OSCILLATOR						
f_{SW}	Switching frequency		400	500	600	kHz
$t_{ON(min)}$	Minimum ON pulse width			150	200	ns
D_{MAX}	Maximum Duty Cycle	f_{SW} = 500kHz	85%	89%		

5.5 Electrical Characteristics (continued)

T_J = –40°C to +125°C, V_{IN} = 5.5V to 36V. Typical values are at T_J = 25°C and V_{IN} = 12V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ENABLE (ENA PIN)						
$V_{EN(R)}$	ENA voltage rising threshold				1.3	V
$V_{EN(F)}$	ENA voltage falling threshold		0.5			V
$V_{EN(H)}$	ENA voltage hysteresis			325		mV
t_{SS}	Internal slow-start time (0 to 100%)		4	8	10	ms
OVERCURRENT PROTECTION						
$I_{HS(OC)}$	High-side peak current limit		1.2	1.55	3.5	A
	Hiccup time before re-start		13	16	21	ms
OUTPUT MOSFET						
$R_{DSON(HS)}$	High-side MOSFET on-resistance	V_{IN} = 12V, $V_{BOOT-SW}$ = 4.5V		100	230	mΩ
$R_{DSON(HS)}$	High-side MOSFET on-resistance	V_{IN} = 5.5V, $V_{BOOT-SW}$ = 4.0V		125		mΩ
THERMAL SHUTDOWN						
$T_{J(SD)}$	Thermal shutdown threshold (1)	Temperature rising	135	162		°C
$T_{J(HYS)}$	Thermal shutdown hysteresis (1)			14		°C

(1) Parameter specified by design, statistical analysis and production testing of correlated parameters. Not production tested.

5.6 Typical Characteristics

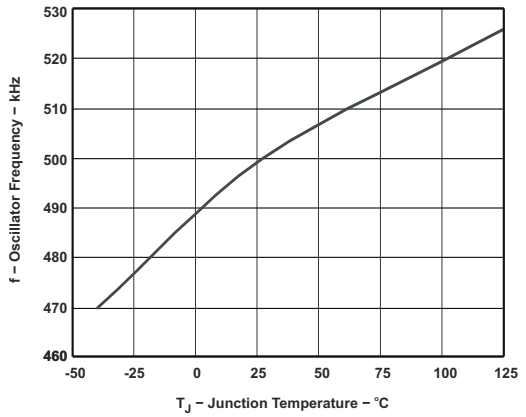


Figure 5-1. Oscillator Frequency vs Junction Temperature

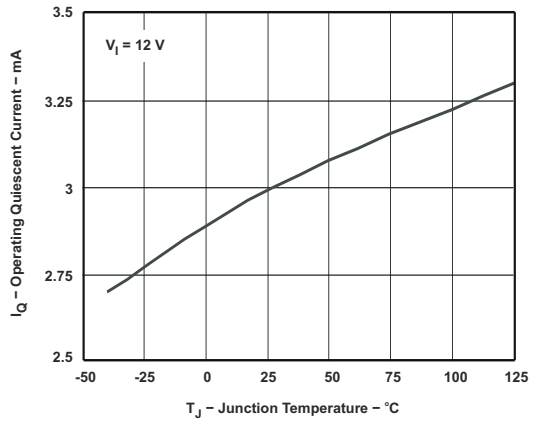


Figure 5-2. Operating Quiescent Current vs Junction Temperature

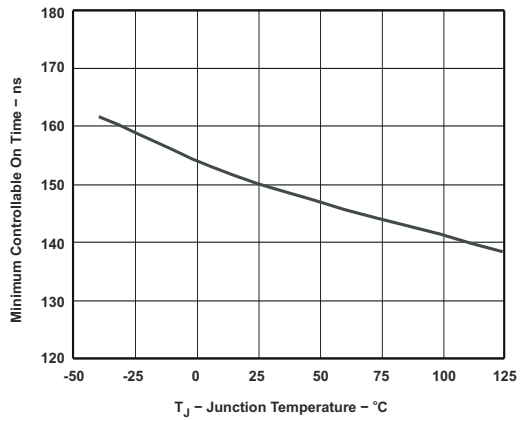


Figure 5-3. Minimum Controllable On Time vs Junction Temperature

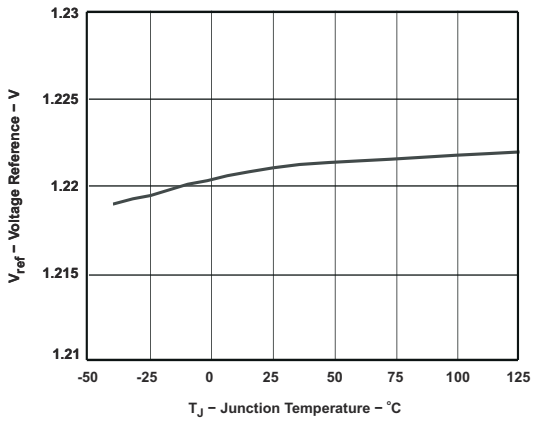


Figure 5-4. Voltage Reference vs Junction Temperature

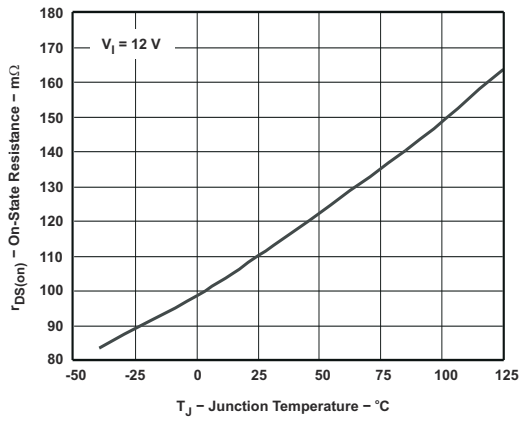


Figure 5-5. On State Resistance vs Junction Temperature

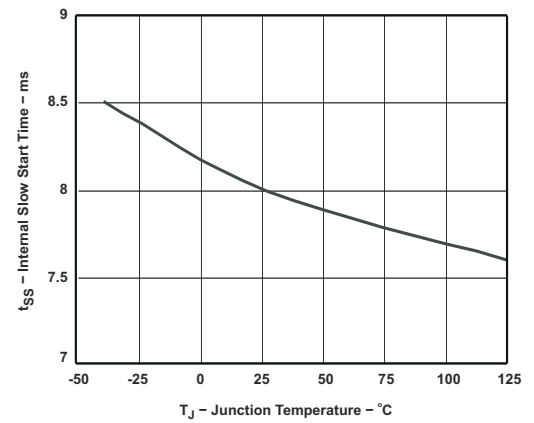


Figure 5-6. Internal Slow Start Time vs Junction Temperature

5.6 Typical Characteristics (continued)

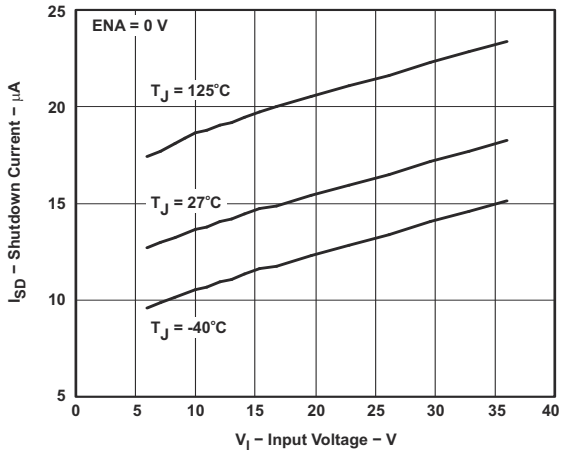


Figure 5-7. Shutdown Quiescent Current vs Input Voltage

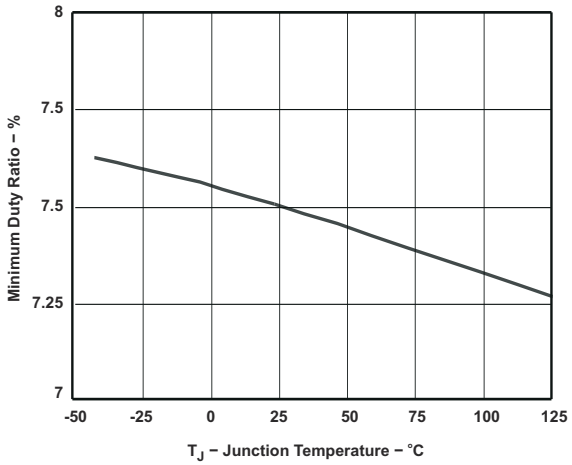


Figure 5-8. Minimum Controllable Duty Ratio vs Junction Temperature

6 Detailed Description

6.1 Overview

The TPS5410-Q1 is a 36V, 1A step-down (buck) regulator with an integrated, high-side, N-Channel MOSFET. These devices implement constant-frequency voltage-mode control with voltage feed-forward for improved line regulation and line transient response. Internal compensation reduces design complexity and external component count.

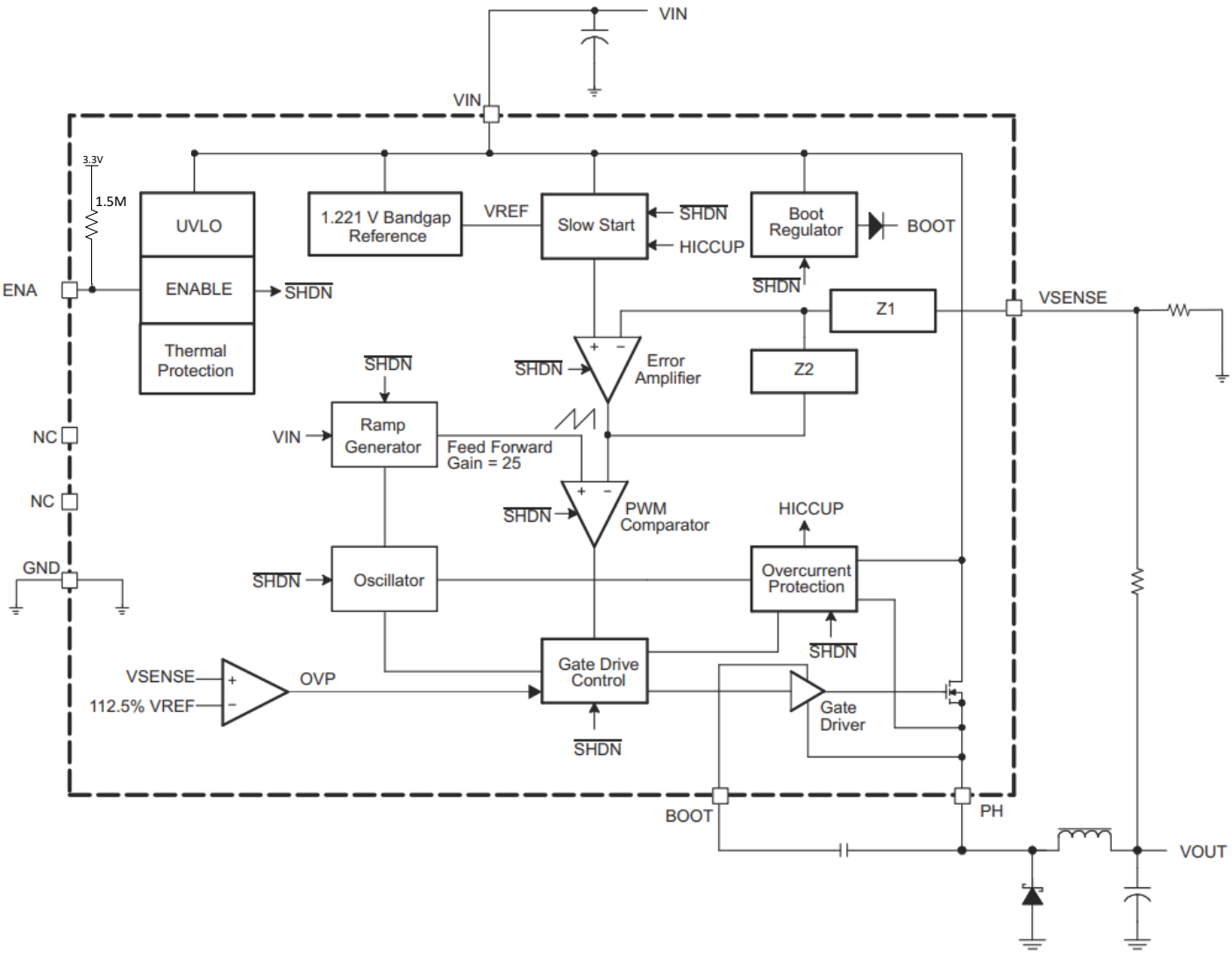
The integrated 110mΩ high-side MOSFET supports high-efficiency power-supply designs capable of delivering 1A of continuous current to a load. The gate-drive bias voltage for the integrated high-side MOSFET is supplied by a bootstrap capacitor connected from the BOOT to PH pins. The TPS5410-Q1 reduces the external component count by integrating the bootstrap recharge diode.

The TPS5410-Q1 has a default input start-up voltage of 5.3V typical. The ENA pin can be used to disable the TPS5410-Q1 reducing the supply current to 18µA. An internal 1.5MΩ pullup resistor enables operation when the ENA pin is left floating. Do not connect a resistor from the ENA pin to ground. The TPS5410-Q1 includes an internal slow-start circuit that slows the output rise time during start up to reduce in rush current and output voltage overshoot.

The minimum output voltage is the internal 1.221V feedback reference. Output overvoltage transients are minimized by an Overvoltage Protection (OVP) comparator. When the OVP comparator is activated, the high-side MOSFET is turned off and remains off until the output voltage is less than 112.5% of the desired output voltage.

Internal cycle-by-cycle overcurrent protection limits the peak current in the integrated high-side MOSFET. For continuous overcurrent fault conditions the TPS5410-Q1 enters hiccup mode overcurrent limiting. Thermal protection protects the device from overheating.

6.2 Functional Block Diagram



6.3 Feature Description

6.3.1 Oscillator Frequency

The internal free running oscillator sets the PWM switching frequency at 500kHz. The 500kHz switching frequency allows less output inductance for the same output ripple requirement resulting in a smaller output inductor.

6.3.2 Voltage Reference

The voltage reference system produces a precision reference signal by scaling the output of a temperature stable bandgap circuit. The bandgap and scaling circuits are trimmed during production testing to an output of 1.221 V at room temperature.

6.3.3 Enable (ENA) and Internal Slow Start

The ENA pin provides electrical on and off control of the regulator. After the ENA pin voltage exceeds the threshold voltage, the regulator starts operation and the internal slow start begins to ramp. If the ENA pin voltage is pulled below the threshold voltage, the regulator stops switching and the internal slow start resets. Connecting the pin to ground or to any voltage less than 0.5V disables the regulator and activate the shutdown mode. The quiescent current of the TPS5410-Q1 in shutdown mode is typically 18µA.

ENA has an internal 1.5MΩ pullup resistor, allowing the user to float the ENA pin. If an application requires controlling the ENA pin, use open drain or open collector output logic to interface with the pin. Do not connect ENA pin with a resistor to ground. To limit the start-up inrush current, an internal slow start circuit is used to ramp up the reference voltage from 0V to the final value linearly. The internal slow start time is 8ms typically.

6.3.4 Undervoltage Lockout (UVLO)

The TPS5410-Q1 incorporates an undervoltage lockout circuit to keep the device disabled when VIN (the input voltage) is below the UVLO start voltage threshold. During power up, internal circuits are held inactive and the internal slow start is grouded until VIN exceeds the UVLO start threshold voltage. Once the UVLO start threshold voltage is reached, the internal slow start is released and device start-up begins. The device operates until VIN falls below the UVLO stop threshold voltage. The typical hysteresis in the UVLO comparator is 330mV.

6.3.5 Boost Capacitor (BOOT)

Connect a 0.01µF low-ESR ceramic capacitor between the BOOT pin and PH pin. This capacitor provides the gate drive voltage for the high-side MOSFET. X7R or X5R grade dielectrics are recommended due to the stable values over temperature.

6.3.6 Output Feedback (VSENSE)

The output voltage of the regulator is set by feeding back the center point voltage of an external resistor divider network to the VSENSE pin. In steady-state operation, the VSENSE pin voltage must be equal to the voltage reference 1.221 V.

6.3.7 Internal Compensation

The TPS5410-Q1 implements internal compensation to simplify the regulator design. Since the TPS5410-Q1 uses voltage mode control, a type 3 compensation network has been designed on chip to provide a high crossover frequency and a high phase margin for good stability. See the *Internal Compensation Network* in the applications section for more details.

6.3.8 Voltage Feed Forward

The internal voltage feed forward provides a constant DC power stage gain despite any variations with the input voltage. This greatly simplifies the stability analysis and improves the transient response. Voltage feed forward varies the peak ramp voltage inversely with the input voltage so that the modulator and power stage gain are constant at the feed forward gain, i.e.

$$\text{Feed Forward Gain} = \frac{\text{VIN}}{\text{Ramp}_{\text{pk-pk}}} \quad (1)$$

The typical feed forward gain of TPS5410-Q1 is 25.

6.3.9 Pulse-Width-Modulation (PWM) Control

The regulator employs a fixed frequency pulse-width-modulator (PWM) control method. First, the feedback voltage (VSENSE pin voltage) is compared to the constant voltage reference by the high gain error amplifier and compensation network to produce a error voltage. Then, the error voltage is compared to the ramp voltage by the PWM comparator. In this way, the error voltage magnitude is converted to a pulse width which is the duty cycle. Finally, the PWM output is fed into the gate drive circuit to control the on-time of the high-side MOSFET.

6.3.10 Overcurrent Liming

Overcurrent limiting is implemented by sensing the drain-to-source voltage across the high-side MOSFET. The drain to source voltage is then compared to a voltage level representing the overcurrent threshold limit. If the drain-to-source voltage exceeds the overcurrent threshold limit, the overcurrent indicator is set true. The system will ignore the overcurrent indicator for the leading edge blanking time at the beginning of each cycle to avoid any turn-on noise glitches.

Once overcurrent indicator is set true, overcurrent limiting is triggered. The high-side MOSFET is turned off for the rest of the cycle after a propagation delay. The overcurrent limiting scheme is called cycle-by-cycle current limiting.

Sometimes under serious overload conditions such as short-circuit, the overcurrent runaway can still happen when using cycle-by-cycle current limiting. A second mode of current limiting is used, i.e. hiccup mode overcurrent limiting. During hiccup mode overcurrent limiting, the voltage reference is grounded and the high-side MOSFET is turned off for the hiccup time. Once the hiccup time duration is complete, the regulator restarts under control of the slow start circuit.

6.3.11 Overvoltage Protection

The TPS5410-Q1 has an overvoltage protection (OVP) circuit to minimize voltage overshoot when recovering from output fault conditions. The OVP circuit includes an overvoltage comparator to compare the VSENSE pin voltage and a threshold of 112.5% x VREF. Once the VSENSE pin voltage is higher than the threshold, the high-side MOSFET will be forced off. When the VSENSE pin voltage drops lower than the threshold, the high-side MOSFET will be enabled again.

6.3.12 Thermal Shutdown

The TPS5410-Q1 protects from overheating with an internal thermal shutdown circuit. If the junction temperature exceeds the thermal shutdown trip point, the voltage reference is grounded and the high-side MOSFET is turned off. The part is restarted under control of the slow start circuit automatically when the junction temperature drops 14°C below the thermal shutdown trip point.

6.4 Device Functional Modes

6.4.1 Minimum Input Voltage

TI recommends the TPS5410-Q1 to operate with input voltages above 5.5V. The typical VIN UVLO threshold is 5.3V, and the device can operate at input voltages down to the UVLO voltage. At input voltages below the actual UVLO voltage the device do not switch. If ENA is floating or externally pulled up to greater up than 1.3V, when $V_{(VIN)}$ passes the UVLO threshold the TPS5410-Q1 becomes active. Switching is enabled and the slow-start sequence is initiated. The TPS5410-Q1 starts linearly ramping up the internal reference voltage from 0V to the final value over the internal slow-start time period.

6.4.2 ENA Control

The enable start threshold voltage is 1.3V maximum. With ENA held below the 0.5V minimum stop threshold voltage the TPS5410-Q1 is disabled and switching is inhibited even if VIN is above the UVLO threshold. The quiescent current is reduced in this state. If the ENA voltage is increased above the max start threshold while $V_{(VIN)}$ is above the UVLO threshold, the device becomes active. Switching is enabled and the slow-start sequence is initiated. The TPS5410-Q1 starts linearly ramping up the internal reference voltage from 0V to the final value over the internal slow-start time period.

7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

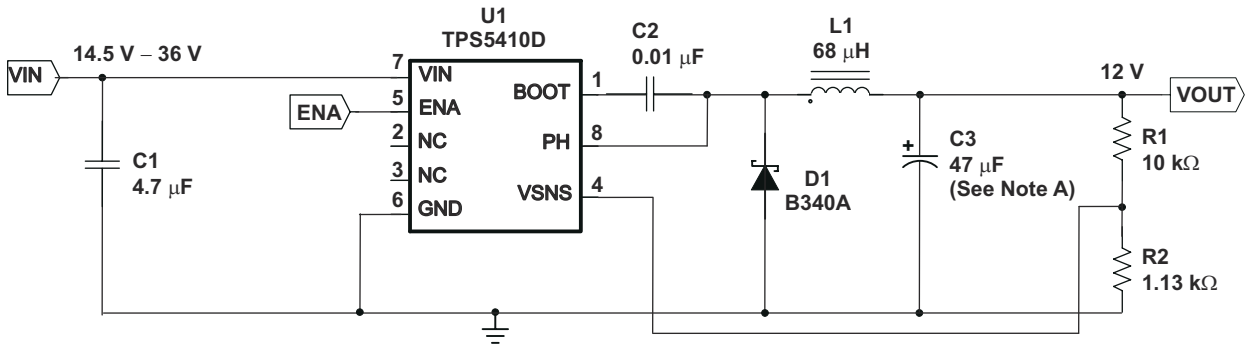
7.1 Application Information

The TPS5410-Q1 is a 1A, step-down regulator with an integrated high-side MOSFET. This device is typically used to convert a higher DC voltage to a lower DC voltage with a maximum available output current of 1A. Example applications are: high density point-of-load regulators for set-top box, DVD, LCD and plasma displays, high power LED supply, car audio, battery chargers, and other 12V and 24V distributed power systems. Use the following design procedure to select component values for the TPS5410. This procedure illustrates the design of a high frequency switching regulator. Alternatively, use the WEBENCH software to generate a complete design. The WEBENCH software uses an iterative design procedure and accesses a comprehensive database of components when generating a design.

7.2 Typical Application

7.2.1 Application Circuits

Figure 7-1 shows the schematic for a typical TPS5410-Q1 application. The TPS5410-Q1 can provide up to 1A output current at a nominal output voltage of 12V.



A. C3 = Tantalum AVX TPSE476M020R0150

Figure 7-1. Application Circuit, 14.5V — 36V to 12V

7.2.1.1 Design Requirements

For this design example, use the following as the input parameters:

DESIGN PARAMETER(1)	EXAMPLE VALUE
Input voltage range	14.5V to 36V
Output voltage	12V
Input ripple voltage	300mV
Output ripple voltage	50mV
Output current rating	1A
Operating frequency	500kHz

(1) As an additional constraint, the design is set up to be small size and low component height.

7.2.1.2 Detailed Design Procedure

The following design procedure can be used to select component values for the TPS5410-Q1. Alternately, see also DC/DC switching regulators for any available software tools to aid in the design process. This section presents a simplified discussion of the design process.

To begin the design process, a few parameters must be determined. The designer must know the following:

- Input voltage range
- Output voltage
- Input ripple voltage
- Output ripple voltage
- Output current rating
- Operating frequency

7.2.1.2.1 Switching Frequency

The switching frequency for the TPS5410-Q1 is internally set to 500kHz. It is not possible to adjust the switching frequency.

7.2.1.2.2 Input Capacitors

The TPS5410-Q1 requires an input decoupling capacitor and, depending on the application, a bulk input capacitor. The minimum recommended value for the decoupling capacitor is 4.7µF. A high quality ceramic type X5R or X7R is required. For some applications, a smaller value decoupling capacitor can be used, if the input voltage and current ripple ratings are not exceeded. The voltage rating must be greater than the maximum input voltage, including ripple. For this design, a 4.7µF capacitor, C1 issued to allow for smaller 1812 case size to be used while maintaining a 50V rating.

This input ripple voltage can be approximated by Equation 2 :

$$\Delta V_{IN} = \frac{I_{OUT(MAX)} \times 0.25}{C_{BULK} \times f_{SW}} + \left(I_{OUT(MAX)} \times ESR_{MAX}\right) \quad (2)$$

Where $I_{OUT(MAX)}$ is the maximum load current, f_{SW} is the switching frequency, C_I is the input capacitor value and ESR_{MAX} is the maximum series resistance of the input capacitor.

The maximum RMS ripple current also needs to be checked. For worst case conditions, this is approximated by Equation 3:

$$I_{CIN} = \frac{I_{OUT(MAX)}}{2} \quad (3)$$

In this example, the calculated input ripple voltage is 137mV, and the RMS ripple current is 0.5A. The maximum voltage across the input capacitors can be VIN max plus delta VIN/2. The chosen input decoupling capacitors are rated for 50V, and the ripple current capacity for each is 3A at 500kHz, providing ample margin. The actual measured input ripple voltage can be larger than the calculated value due to the output impedance of the input voltage source, decrease in actual capacitance due to bias voltage and parasitics associated with the layout.

CAUTION

The maximum ratings for voltage and current are not to be exceeded under any circumstance.

Additionally, some bulk capacitance can be needed, especially if the TPS5410-Q1 circuit is not located within approximately 2 inches from the input voltage source. The value for this capacitor is not critical but it must be rated to handle the maximum input voltage including ripple voltage and must filter the output so that input ripple voltage is acceptable.

7.2.1.2.3 Output Filter Components

Two components need to be selected for the output filter, L1 and C3. Since the TPS5410-Q1 is an internally compensated device, a limited range of filter component types and values can be supported.

7.2.1.2.3.1 Inductor Selection

To calculate the minimum value of the output inductor, use Equation 4:

$$L_{MIN} = \frac{V_{OUT} \times \left(V_{IN(MAX)} - V_{OUT}\right)}{V_{IN(max)} \times K_{IND} \times I_{OUT} \times F_{SW} \times 0.8} \quad (4)$$

K_{IND} is a coefficient that represents the amount of inductor ripple current relative to the maximum output current. Three things need to be considered when determining the amount of ripple current in the inductor: the peak to peak ripple current affects the output ripple voltage amplitude, the ripple current affects the peak switch current, and the amount of ripple current determines at what point the circuit becomes discontinuous. For designs using the TPS5410-Q1, K_{IND} of 0.2 to 0.3 yields good results. Low output ripple voltages is obtained when paired with the proper output capacitor, the peak switch current is below the current limit set point, and low load currents can be sourced before discontinuous operation.

For this design example, use K_{IND} = 0.3, and the minimum inductor value is 66µH. The next highest standard value used in this design is 68µH.

For the output filter inductor, it is important that the RMS current and saturation current ratings not be exceeded. The RMS inductor current can be found from Equation 5:

$$I_{L(RMS)} = \sqrt{I^2_{OUT(MAX)} + \frac{1}{12} \times \left(\frac{V_{OUT} \times \left(V_{IN(MAX)} - V_{OUT}\right)}{V_{IN(MAX)} \times L_{OUT} \times F_{SW} \times 0.8}\right)^2} \quad (5)$$

and the peak inductor current can be determined using Equation 6:

$$I_{L(PK)} = I_{OUT(MAX)} + \frac{V_{OUT} \times \left(V_{IN(MAX)} - V_{OUT}\right)}{1.6 \times V_{IN(MAX)} \times L_{OUT} \times F_{SW}} \quad (6)$$

For this design, the RMS inductor current is 1.004A, and the peak inductor current is 1.147A. The chosen inductor is a Coilcraft MSS1260-683 type. The nominal inductance is 68µH. It has a saturation current rating of 2.3A and a RMS current rating of 2.3A, which meets the requirements. Inductor values for use with the TPS5410-Q1 are in the range of 10µH to 100µH.

7.2.1.2.3.2 Capacitor Selection

The important design factors for the output capacitor are dc voltage rating, ripple current rating, and equivalent series resistance (ESR). The dc voltage and ripple current ratings cannot be exceeded. The ESR is important because along with the inductor ripple current the ESR determines the amount of output ripple voltage. The actual value of the output capacitor is not critical, but some practical limits do exist. Consider the relationship between the desired closed loop crossover frequency of the design and LC corner frequency of the output filter. Due to the design of the internal compensation, TI recommends to keep the closed loop crossover frequency in the range 3kHz to 30kHz as this frequency range has adequate phase boost to allow for stable operation. For this design example, the intended closed loop crossover frequency is between 2590Hz and 24kHz, and below the ESR zero of the output capacitor. Under these conditions, the closed loop crossover frequency is related to the LC corner frequency as:

$$f_{CO} = \frac{f_{LC}^{2}}{85\ V_{OUT}} \tag{7}$$

and the desired output capacitor value for the output filter to:

$$C_{OUT} = \frac{1}{3357 \times L_{OUT} \times f_{CO} \times V_{OUT}} \tag{8}$$

For a desired crossover of 10kHz and a 68µH inductor, the calculated value for the output capacitor is 36.5µF. The capacitor type must be chosen so that the ESR zero is above the loop crossover. The maximum ESR is:

$$ESR_{MAX} = \frac{1}{2\pi \times C_{OUT} \times f_{CO}} \tag{9}$$

The maximum ESR of the output capacitor also determines the amount of output ripple as specified in the initial design parameters. The output ripple voltage is the inductor ripple current times the ESR of the output filter. Check that the maximum specified ESR as listed in the capacitor data sheet results in an acceptable output ripple voltage:

$$V_{PP}(MAX) = \frac{ESR_{MAX} \times V_{OUT} \times \left(V_{IN(MAX)} - V_{OUT}\right)}{N_C \times V_{IN(MAX)} \times L_{OUT} \times F_{SW} \times 0.8} \tag{10}$$

Where:

ΔV_{PP} is the desired peak-to-peak output ripple.

N_C is the number of parallel output capacitors.

F_{SW} is the switching frequency.

The minimum ESR of the output capacitor must also be considered. For a good phase margin, if the ESR is zero when the ESR is at its minimum, it must not be above the internal compensation poles at 24kHz and 54 kHz.

The selected output capacitor must also be rated for a voltage greater than the desired output voltage plus one half the ripple voltage. Any derating amount must also be included. The maximum RMS ripple current in the output capacitor is given by Equation 11:

$$I_{COUT(RMS)} = \frac{1}{\sqrt{12}} \times \left[\frac{V_{OUT} \times \left(V_{IN(MAX)} - V_{OUT}\right)}{V_{IN(MAX)} \times L_{OUT} - F_{SW} \times 0.8 \times N_C}\right] \tag{11}$$

Where:

N_C is the number of output capacitors in parallel.

F_{SW} is the switching frequency.

For this design example, a single 47µF output capacitor is chosen for C3. This value is close to the calculated value of 36.5µF and yields an actual closed loop cross over frequency of 10.05kHz. The calculated RMS ripple current is 84.9mA and the maximum ESR required is 339mΩ. A capacitor that meets these requirements is a AVX TPSE476M020R0150, rated at 20V with a maximum ESR of 150mΩ and a ripple current rating of 1.369A. This capacitor results in a peak-to-peak output ripple of 44mV using equation 10. An additional small 0.1µF ceramic bypass capacitor can also used, but is not included in this design.

Other capacitor types can be used with the TPS5410-Q1, depending on the needs of the application.

7.2.1.2.4 Output Voltage Setpoint

The output voltage of the TPS5410-Q1 is set by a resistor divider (R1 and R2) from the output to the VSENSE pin. Calculate the R2 resistor value for the output voltage of 12V using Equation 12:

$$R2 = \frac{R1 \times 1.221}{V_{OUT} - 1.221} \tag{12}$$

For any TPS5410-Q1 design, start with an R1 value of 10kΩ. R2 is then 1.13kΩ.

7.2.1.2.5 Boot Capacitor

The boot capacitor must be 0.01µF.

7.2.1.2.6 Catch Diode

The TPS5410-Q1 is designed to operate using an external catch diode between PH and GND. The selected diode must meet the absolute maximum ratings for the application: Reverse voltage must be higher than the maximum voltage at the PH pin, which is VINMAX + 0.5V. Peak current must be greater than IOUTMAX plus on half the peak-to-peak inductor current. Forward voltage drop must be small for higher efficiencies. It is important to note that the catch diode conduction time is typically longer than the high-side FET on time; therefore, the diode parameters improve the overall efficiency. Additionally, check that the device chosen is capable of dissipating the power losses. For this design, a Diodes, Inc. B340A is chosen, with a reverse voltage of 40V, forward current of 3A, and a forward voltage drop of 0.5V.

7.2.1.2.7 Limits of Operation

7.2.1.2.7.1 Output Voltage Limitations

Due to the internal design of the TPS5410-Q1, there are both upper and lower output voltage limits for any given input voltage. The upper limit of the output voltage set point is constrained by the maximum duty cycle of 87% and is given by:

$$V_{OUTMAX} = 0.87 \times \left(\left(V_{INMIN} - I_{OMAX} \times 0.230\right) + V_D\right) - \left(I_{OMAX} \times R_L\right) - V_D \tag{13}$$

Where:

V_{INMIN} = minimum input voltage

I_{OMAX} = maximum load current

V_D = catch diode forward voltage.

R_L= output inductor series resistance.

This equation assumes maximum on resistance for the internal high side FET.

The lower limit is constrained by the minimum controllable on time which can be as high as 200 ns. The approximate minimum output voltage for a given input voltage and minimum load current is given by:

$$V_{OUTMIN} = 0.12 \times \left(\left(V_{INMAX} - I_{OMIN} \times 0.110\right) + V_D\right) - \left(I_{OMIN} \times R_L\right) - V_D \tag{14}$$

Where:

V_{INMAX} = maximum input voltage

I_{OMIN} = minimum load current

V_D = catch diode forward voltage.

R_L= output inductor series resistance.

This equation assumes nominal on resistance for the high side FET and accounts for worst case variation of operating frequency set point. Any design operating near the operational limits of the device must be checked to assure proper functionality.

7.2.1.2.7.2 Internal Compensation Network

The design equations given in the example circuit can be used to generate circuits using the TPS5410-Q1. These designs are based on certain assumptions, and always select output capacitors within a limited range of ESR values. If a different capacitor type is desired, it can be possible to fit one to the internal compensation of the TPS5410-Q1. Equation 15 gives the nominal frequency response of the internal voltage-mode type III compensation network:

$$H(s) = \frac{\left(1 + \frac{s}{2\pi \times Fz1}\right) \times \left(1 + \frac{s}{2\pi \times Fz2}\right)}{\left(\frac{s}{2\pi \times Fp0}\right) \times \left(1 + \frac{s}{2\pi \times Fp1}\right) \times \left(1 + \frac{s}{2\pi \times Fp2}\right) \times \left(1 + \frac{s}{2\pi \times Fp3}\right)} \quad (15)$$

Where

Fp0 = 2165Hz, Fz1 = 2170Hz, Fz2 = 2590Hz

Fp1 = 24kHz, Fp2 = 54kHz, Fp3 = 440kHz

Fp3 represents the non-ideal parasitics effect.

Using this information along with the desired output voltage, feed forward gain and output filter characteristics, the closed loop transfer function can be derived.

7.2.1.2.7.3 Thermal Calculations

The following formulas show how to estimate the device power dissipation under continuous conduction mode operations. They must not be used if the device is working at light loads in the discontinuous conduction mode.

Conduction Loss: Pcon = $I_{OUT}{}^2$ x Rds(on) x V_{OUT} / V_{IN}

Switching Loss: Psw = V_{IN} x I_{OUT} x 0.01

Quiescent Current Loss: Pq = V_{IN} x 0.01

Total Loss: Ptot = Pcon + Psw + Pq

Given T_A => Estimated Junction Temperature: $T_J = T_A$ + Rth x Ptot

Given T_{JMAX} = 125°C => Estimated Maximum Ambient Temperature: $T_{AMAX} = T_{JMAX}$ – Rth x Ptot

7.2.1.3 Application Curves

The performance graphs in Figure 7-2 - Figure 7-9 are applicable to the circuit in Figure 7-1. T_A = 25°C. unless otherwise specified.

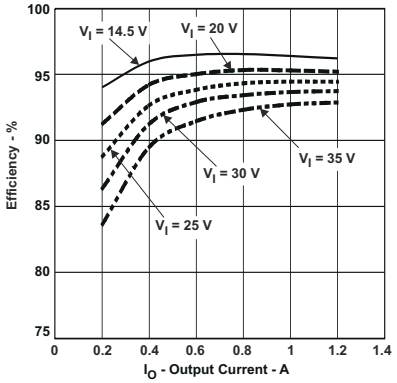


Figure 7-2. Efficiency vs. Output Current

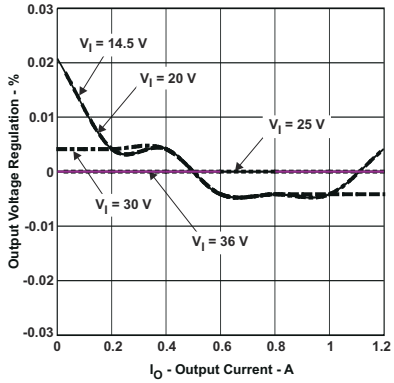


Figure 7-3. Output Voltage Regulation % vs. Output Current

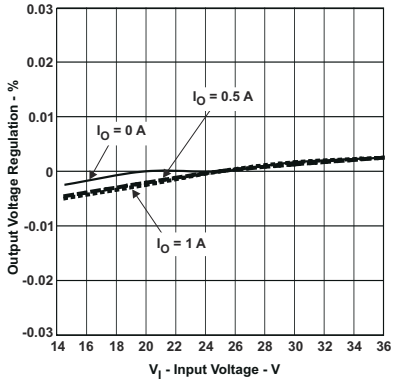


Figure 7-4. Output Voltage Regulation % vs. Input Voltage

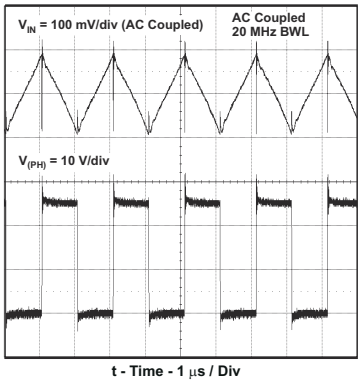


Figure 7-5. Input Voltage Ripple and PH Node, I_O = 1A

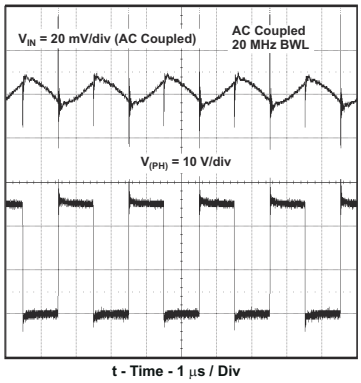


Figure 7-6. Output Voltage Ripple and PH Node, I_O = 1A

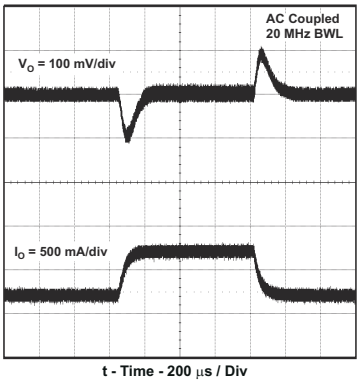


Figure 7-7. Transient Response, I_O Step 0.25 to 0.75A

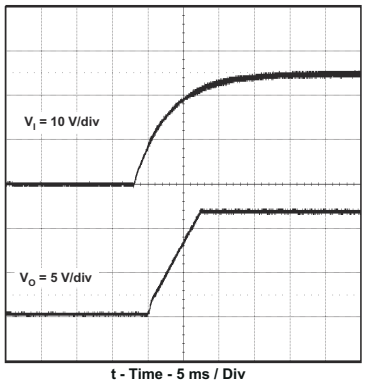


Figure 7-8. Startup Waveform, V_I and V_O

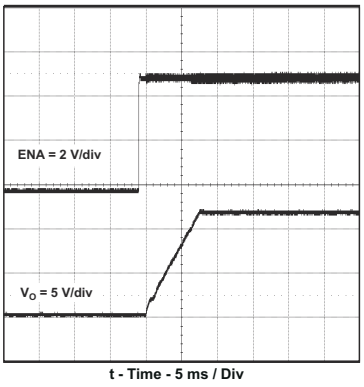
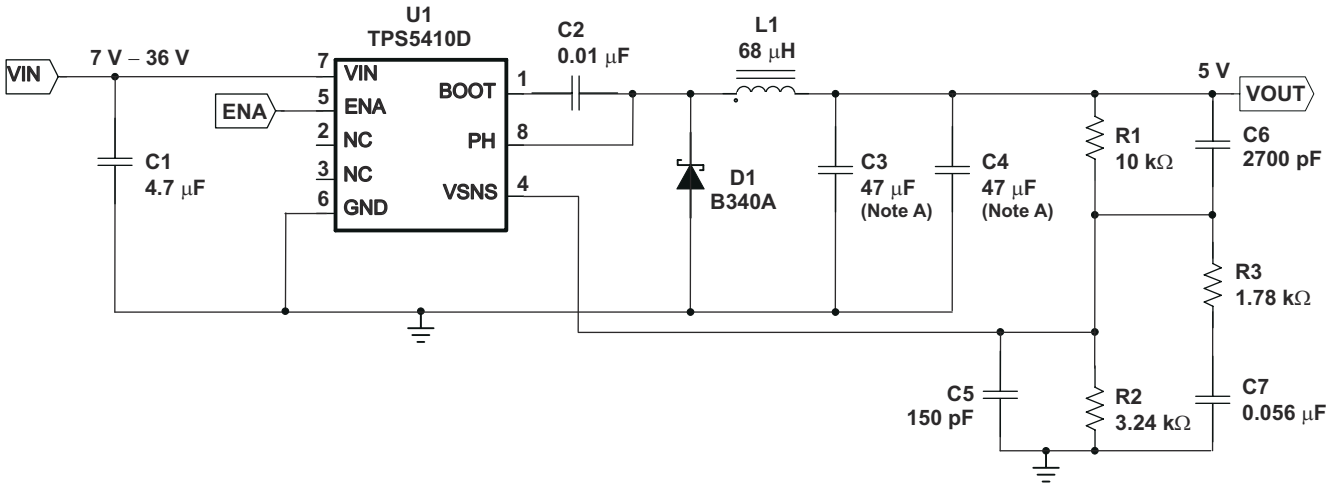


Figure 7-9. Startup Waveform, ENA and V_O

7.2.2 Additional Circuits

Figure 7-10 shows an application circuit using all ceramic capacitors for the input and output filters. The design procedure is similar to those given for the design example, except for the selection of the output filter capacitor values and the design of the additional compensation components required to stabilize the circuit.



A. C3, C4 = Ceramic TDKC4532X5R1A476MT

Figure 7-10. 7V — 36V Input to 5V Output Application Circuit with Ceramic Capacitors

7.2.2.1 Design Requirements

For this design example, use Section 7.2.1.1 as the input parameters.

7.2.2.2 Detailed Design Procedure

7.2.2.2.1 Output Filter Capacitor Selection

When using ceramic output filer capacitors, the recommended LC resonant frequency must be no more than 7kHz. Because the output inductor is already selected at 68µH, this value limits the minimum output capacitor value to:

$$C_O\,(MIN) \geq \frac{1}{(2\pi \times 7000)^2 \times L_O} \tag{16}$$

The minimum capacitor value is calculated to be 7.6µF. For this circuit, a larger value of capacitor yields better transient response. Two output capacitors are used for C3 and C4 with a value of 47uF each. Note that the

actual capacitance of ceramic capacitors decreases with applied voltage. In this case, the effective value used for the calculations is approximately 70% of the rated value or 70µF.

7.2.2.2.2 External Compensation Network

When using ceramic output capacitors, additional circuitry is required to stabilize the closed loop system. For this circuit the external components are R3, C5, C6 and C7. To determine the value of these components, first calculate the LC resonant frequency of the output filter:

$$F_{LC} = \frac{1}{2\pi \sqrt{L_O \times C_O (EFF)}} \quad (17)$$

For this example, the effective resonant frequency is calculated as 2306Hz.

The network composed of R1, R2, R3, C5, C6, and C7 has two poles and two zeros that are used to tailor the overall response of the feedback network to accommodate the use of the ceramic output capacitors. The pole and zero locations are given by the following equations:

$$Fp1 = 500000 \times \frac{V_O}{F_{LC}} \quad (18)$$

$$Fz1 = 0.7 \times F_{LC} \quad (19)$$

$$Fz2 = 2.5 \times F_{LC} \quad (20)$$

The final pole is located at a frequency too high to be of concern. The values for R1 and R2 are fixed by the 5V output voltage as calculated using Equation 12. Now the values of R3, C5, C6, and C7 are determined using Equation 21, Equation 22, and Equation 23:

$$C7 = \frac{1}{2\pi \times Fp1 \times (R1 \parallel R2)} \quad (21)$$

$$R3 = \frac{1}{2\pi \times Fz1 \times C7} \quad (22)$$

$$C6 = \frac{1}{2\pi \times Fz2 \times R1} \quad (23)$$

For this design, using the closest standard values, C7 is 0.056µF, R3 is 1.76kΩ and C6 is 2700pF. C5 is added to improve load regulation performance. It is effectively in parallel with C6 in the location of the second pole frequency, so must be small in relationship to C6. C5 must be less the 1/10 the value of C6. For this example, 150pF works well.

For additional information on external compensation of the TPS5410-Q1 or other wide voltage range SWIFT converter devices, see *Using TPS5410/20/30/31 With Aluminum/Ceramic Output Capacitors* application note.

7.2.2.3 Application Curves

The performance graphs in Figure 7-11 - Figure 7-16 are applicable to the circuit in Figure 7-10. T_A = 25°C. unless otherwise specified.

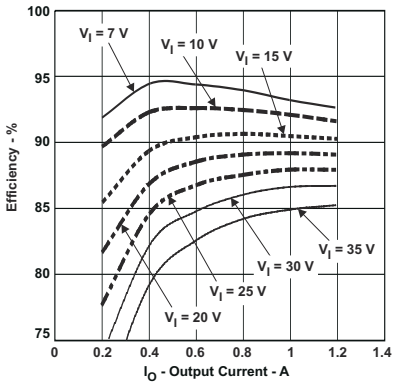


Figure 7-11. Efficiency vs. Output Current

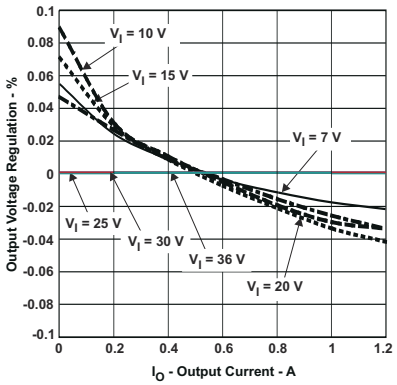


Figure 7-12. Output Voltage Regulation % vs. Output Current

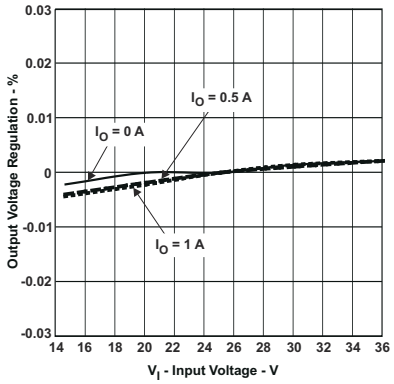


Figure 7-13. Output Voltage Regulation % vs. Input Voltage

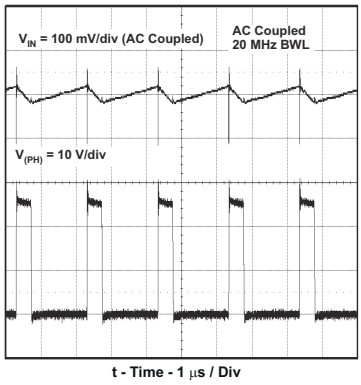


Figure 7-14. Input Voltage Ripple and PH Node, I_O = 1A

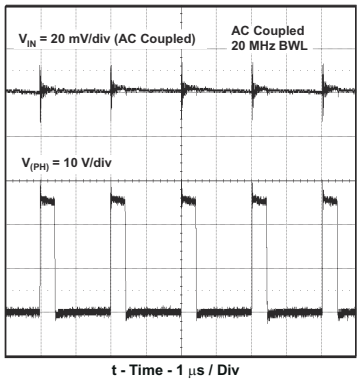


Figure 7-15. Output Voltage Ripple and PH Node, I_O = 1A

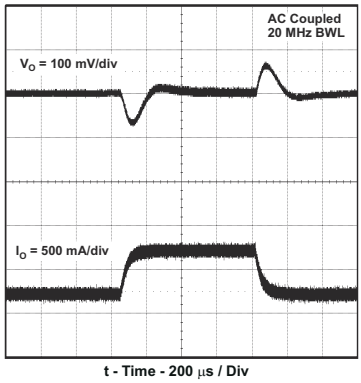


Figure 7-16. Transient Response, I_O Step 0.25 to 0.75A

7.3 Power Supply Recommendations

The TPS5410-Q1 is designed to operate from an input voltage supply range between 5.5V and 36V. This input supply must remain within the input voltage supply range. If the input supply is located more than a few inches from the TPS5410-Q1, converter bulk capacitance can be required in addition to the ceramic bypass capacitors. An electrolytic capacitor with a value of 100µF is a typical choice.

7.4 Layout

7.4.1 Layout Guidelines

Connect a low ESR ceramic bypass capacitor to the VIN pin. Care must be taken to minimize the loop area formed by the bypass capacitor connections, the VIN pin, and the TPS5410-Q1 ground pin. The best way to do this is to extend the top side ground area from under the device adjacent to the VIN trace, and place the bypass capacitor as close as possible to the VIN pin. The minimum recommended bypass capacitance is 4.7µF ceramic with a X5R or X7R dielectric.

There must be a ground area on the top layer directly underneath the IC to connect the GND pin of the device and the anode of the catch diode. The GND pin must be tied to the PCB ground by connecting it to the ground area under the device as shown in Figure 7-17.

The PH pin must be routed to the output inductor, catch diode and boot capacitor. Since the PH connection is the switching node, the inductor must be located close to the PH pin, and the area of the PCB conductor minimized to prevent excessive capacitive coupling. The catch diode must also be placed close to the device to minimize the output current loop area. Connect the boot capacitor between the phase node and the BOOT pin as shown. Keep the boot capacitor close to the IC and minimize the conductor trace lengths. The component placements and connections shown work well, but other connection routings can also be effective.

Connect the output filter capacitor(s) as shown between the VOUT trace and GND. It is important to keep the loop formed by the PH pin, Lout, Cout and GND as small as is practical.

Connect the VOUT trace to the VSENSE pin using the resistor divider network to set the output voltage. Do not route this trace too close to the PH trace. Due to the size of the IC package and the device pinout, the trace can need to be routed under the output capacitor. The routing can be done on an alternate layer if a trace under the output capacitor is not desired.

If the grounding scheme shown is used via a connection to a different layer to route to the ENA pin.

7.4.2 Layout Example

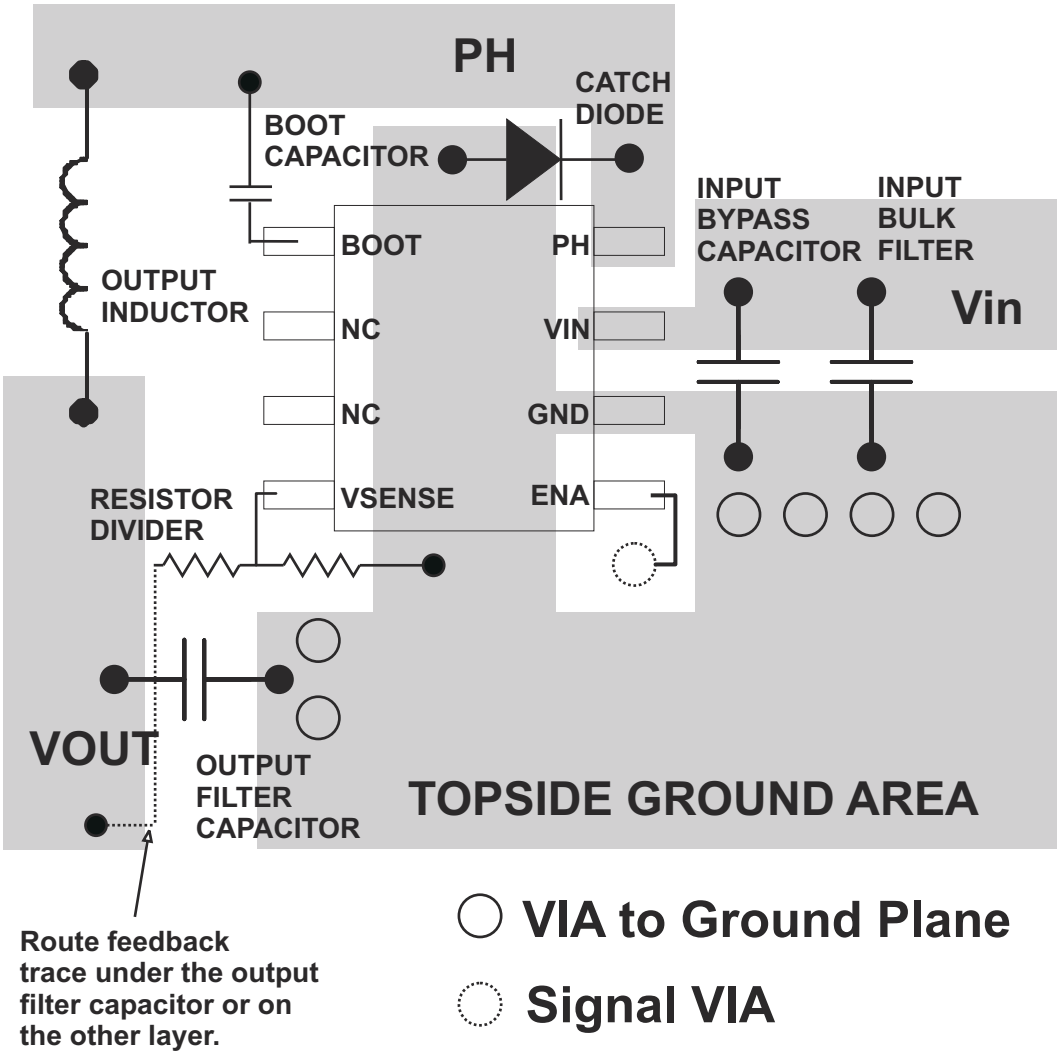


Figure 7-17. Design Layout

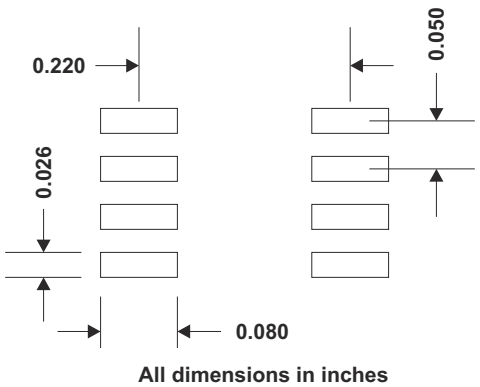


Figure 7-18. TPS5410-Q1 Land Pattern

8 Device and Documentation Support

8.1 Documentation Support

8.1.1 Related Documentation

For related documentation, see the following:

Texas Instruments, *Using TPS5410/20/30/31 With Aluminum/Ceramic Output Capacitors* application note

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

8.4 Trademarks

SWIFT™ and TI E2E™ are trademarks of Texas Instruments.
All trademarks are the property of their respective owners.

8.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (January 2024) to Revision B (April 2026) **Page**

- Updated the document title to include automotive specification....1
- Deleted out of date SWIFT documentation link in the *Features* 1
- Updated the ENA pin description by adding information about internal 1.5MΩ pullup resistor in *Pin Configuration and Functions* 3
- Added table note 3 in Absolute Maximum Ratings section....3
- Added table note 3 in Thermal Information section....4
- Updated the *Detailed Description* section to comply with current standards....8
- Added the *Overview* section....8
- Deleted the 5uA current source and added a 1.5MΩ pullup resistor in the functional block diagram....9
- Updated the *Enable (ENA) and Internal Slow Start* section by deleting current information and adding internal 1.5MΩ pullup resistor information....9
- Added the *Device Functional Modes* section....11
- Added the *Application and Implementation* section to comply with current standards....12
- Added the *Application Information* section....12
- Added the *Design Requirements* section....19
- Added the *Detailed Design Procedure* section....19
- Added the *Power Supply Recommendations* section....22

Changes from Revision * (September 2009) to Revision A (January 2024) **Page**

- Updated the numbering format for tables, figures, and cross-references throughout the document....1
- Updated to new format which does not include specific parameter names and does include min and max columns. TJ called out in header. Pin names are used rather than signal names. BOOT and PH voltages now marked as output voltage. Footnotes updated and Note 2 removed. ESD specifications moved to separate table....3
- Changed BOOT to PH Absolute Maximum to 6 V maximum....3
- Deleted Absolute Maximum BOOT to GND maximum voltage....3
- Added separate ESD table....4
- Changed HBM ESD to ±2000 V, changed CDM to ±750 V, deleted MM....4
- Added Recommended operating V_I input voltage....4
- Updated Dissipation Ratings table with more detailed Thermal Information table....4
- Added condition for typical specifications EC table's header, added parameter names, and used pin names in parameter descriptions. Footnote added....4
- Updated the following test conditions: V_{FB}, D_{MAX}, and $R_{DSON(HS)}$....4
- Updated the following typical specifications in the EC table: $I_{Q(VIN)}$, $I_{SD(VIN)}$, $VIN_{UVLO(H)}$, $V_{EN(H)}$, and $R_{DSON(HS)}$....4
- Updated the following typical specification in the EC table: $I_{HS(OC)}$ 4

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS5410QDRQ1	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	Call TI | Nipdau	Level-2-260C-1 YEAR	-40 to 125	5410Q
TPS5410QDRQ1.A	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	5410Q

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

OTHER QUALIFIED VERSIONS OF TPS5410-Q1 :

- Catalog : TPS5410

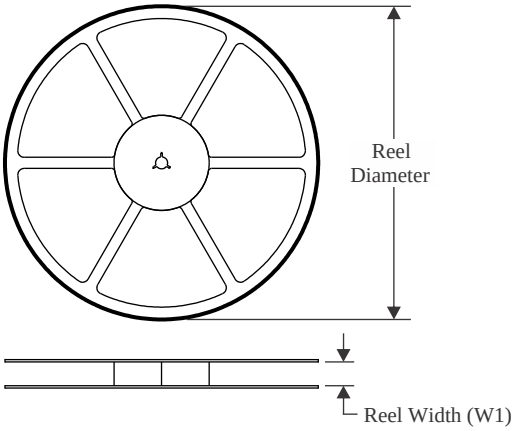
- Enhanced Product : TPS5410-EP

NOTE: Qualified Version Definitions:

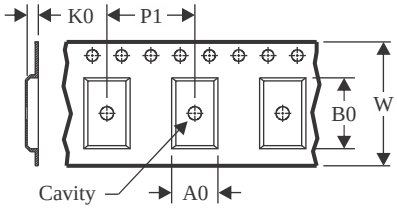
- Catalog - TI's standard catalog product
- Enhanced Product - Supports Defense, Aerospace and Medical Applications

TAPE AND REEL INFORMATION

REEL DIMENSIONS

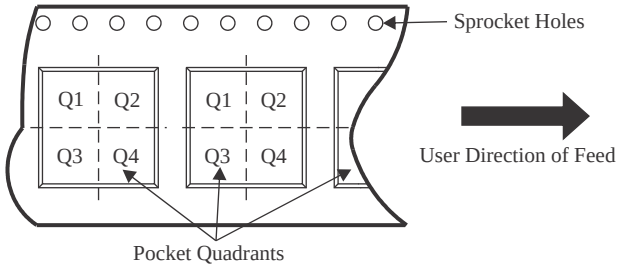


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

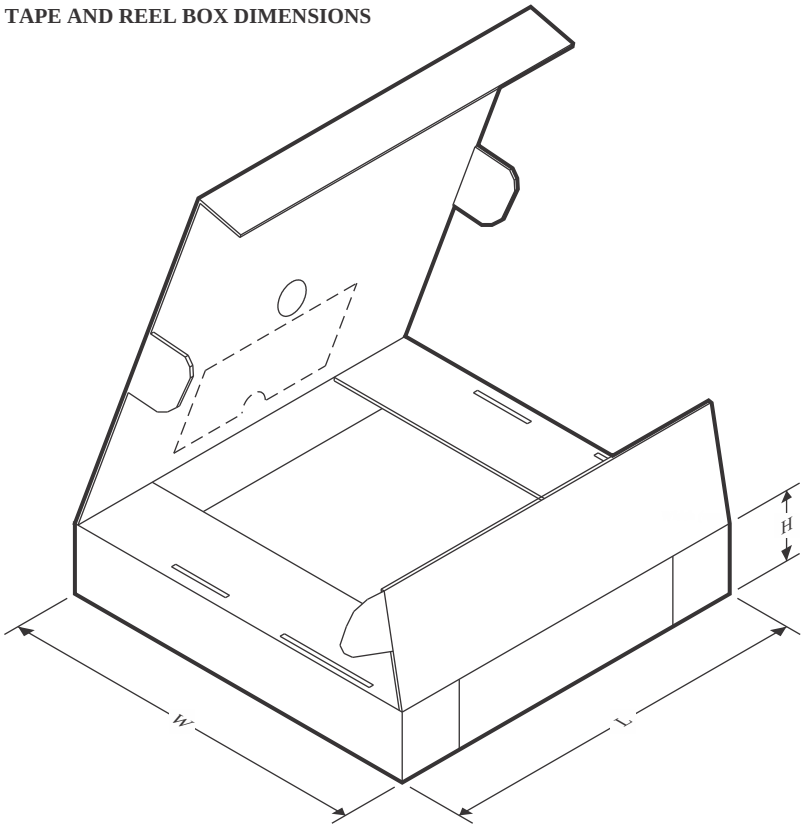
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

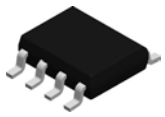
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS5410QDRQ1	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS5410QDRQ1	SOIC	D	8	2500	353.0	353.0	32.0

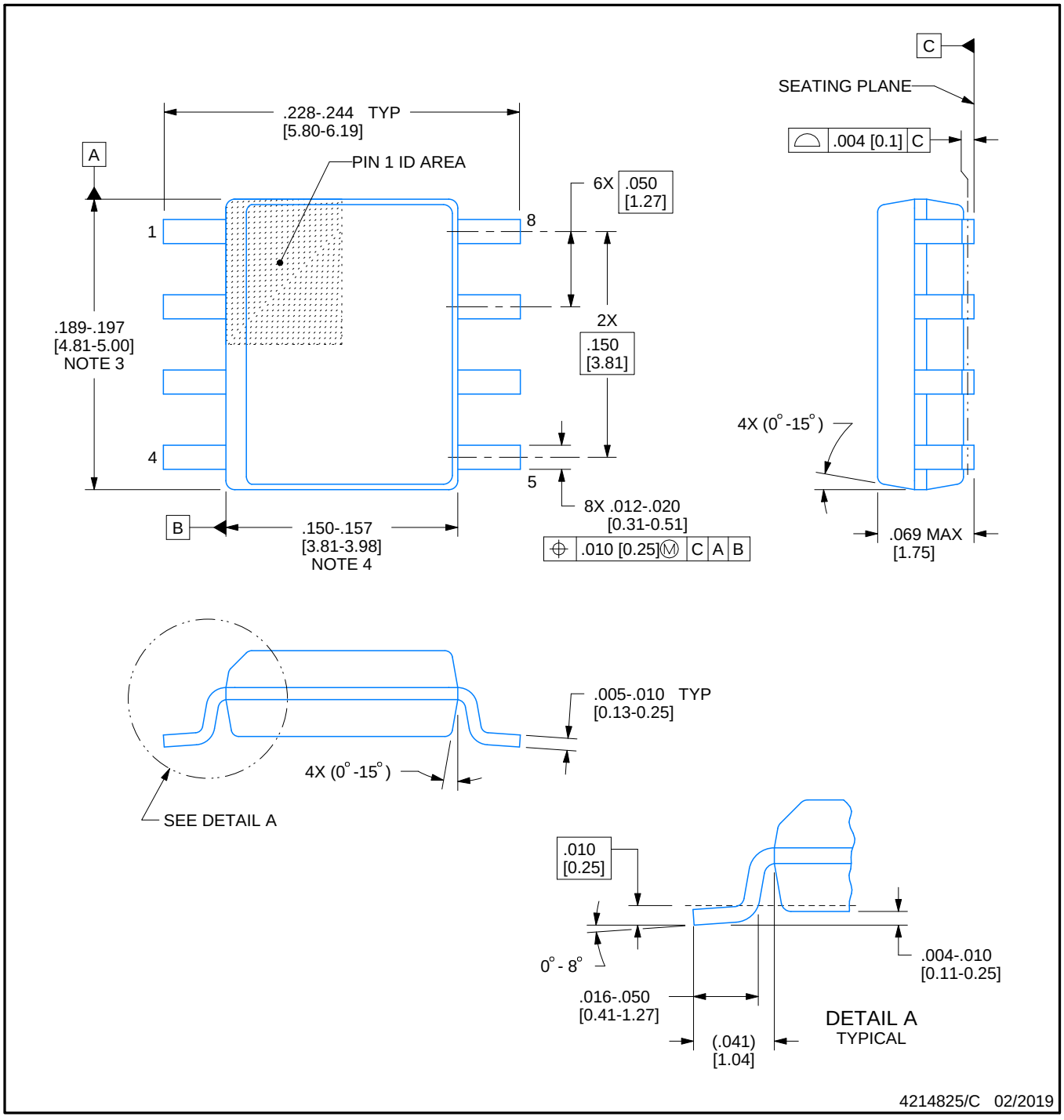


PACKAGE OUTLINE

D0008A

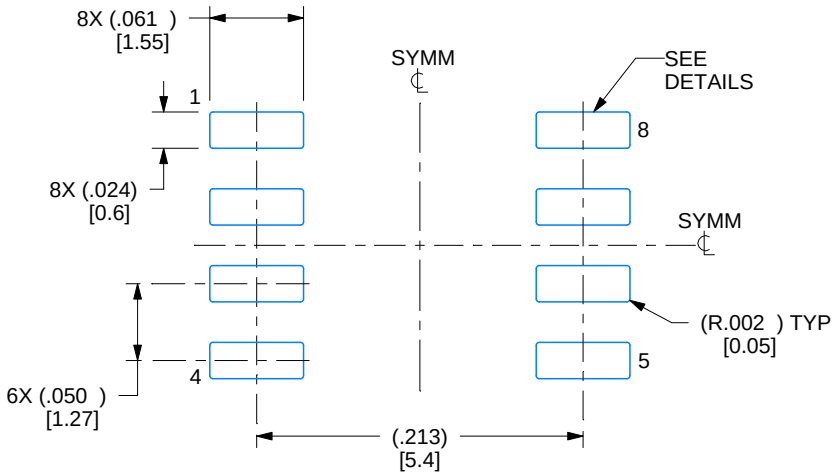
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

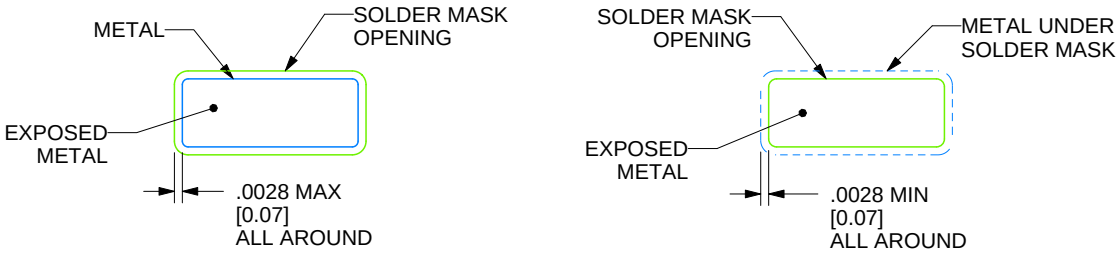


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

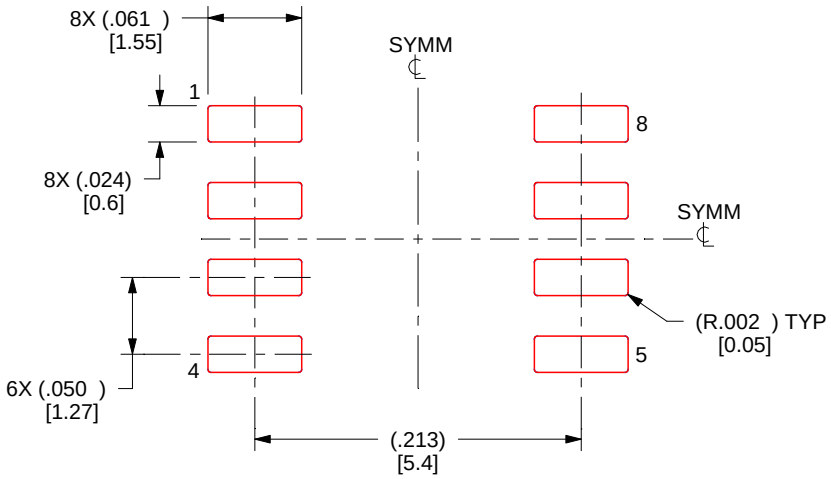
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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